

IS31AP2006

3W MONO FILTER-LESS CLASS-D AUDIO POWER AMPLIFIER

August 2015

GENERAL DESCRIPTION

The IS31AP2006 is a high efficiency, 3W mono Class-D audio power amplifier. A low noise, filter-less PWM architecture eliminates the output filter, reducing external component count, system cost, and simplifying design.

Operating in a single 5V supply, IS31AP2006 is capable of driving 4Ω speaker load at a continuous average output of 3W with 10% THD+N. The IS31AP2006 has high efficiency with speaker load compared to a typical class-AB amplifier.

In cellular handsets, the earpiece, speaker phone, and melody ringer can each be driven by the IS31AP2006. The gain of IS31AP2006 is externally configurable which allows independent gain control from multiple sources by summing signals from each function.

The IS31AP2006 is available in DFN-8 (3mm×3mm) and SOP-8 packages.

FEATURES

- 5V supply at THD = 10%
 - 3W into 4Ω (Typ.)
 - 1.70W into 8Ω (Typ.)
- Efficiency at 5V:
 - 83% at 400mW with a 4Ω speaker
 - 89% at 400mW with an 8Ω speaker
- Optimized PWM output stage eliminates LC output filter
- Fully differential design reduces RF rectification and eliminates bypass capacitor
- Integrated pop-and-click suppression circuitry
- DFN-8 (3mm×3mm) and SOP-8 packages

APPLICATIONS

- Wireless or cellular handsets and PDAs
- Portable DVD player
- Notebook PC
- Portable radio
- Educational toys
- USB speakers
- Portable gaming

TYPICAL APPLICATION CIRCUIT

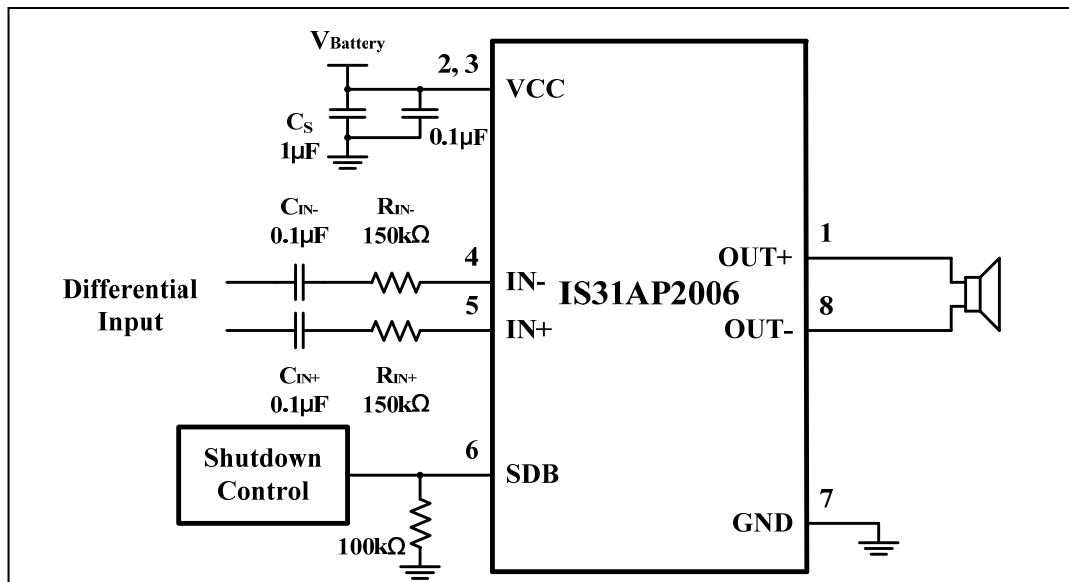


Figure 1 Typical Application Circuit (Differential Input)

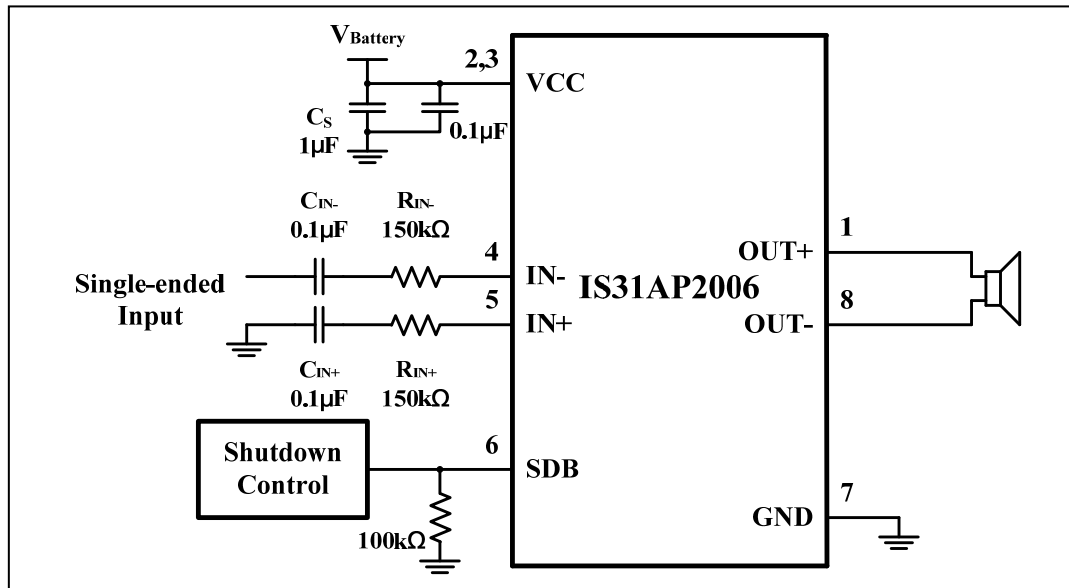
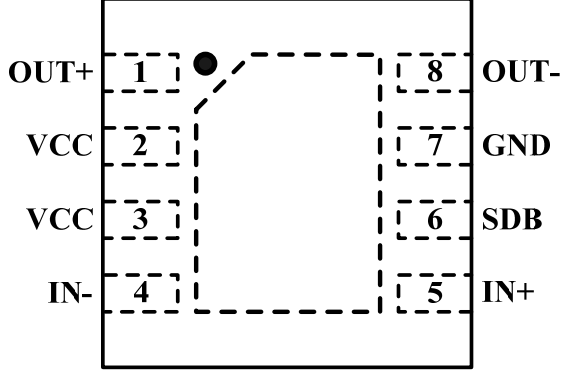
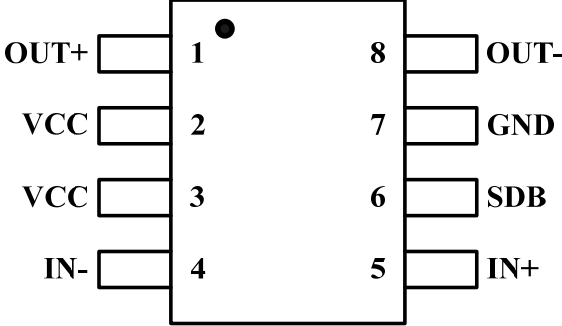


Figure 2 Typical Application Schematic (Single-ended Input)

IS31AP2006

PIN CONFIGURATION

Package	Pin Configuration (Top view)
DFN-8	
SOP-8	

PIN DESCRIPTION

No.	Pin	Description
1	OUT+	Positive audio output.
2, 3	VCC	Power supply.
4	IN-	Negative audio input.
5	IN+	Positive audio input.
6	SDB	Shutdown control, active low logic.
7	GND	Ground.
8	OUT-	Negative audio output.
	Thermal Pad (Only for DFN package)	Connect to GND.



IS31AP2006

ORDERING INFORMATION

Industrial Range: -40°C to +85°C

Order Part No.	Package	QTY/Reel
IS31AP2006-DLS2-TR	DFN-8, Lead-free	2500
IS31AP2006-GRLS2-TR	SOP-8, Lead-free	

Copyright © 2015 Integrated Silicon Solution, Inc. All rights reserved. ISSI reserves the right to make changes to this specification and its products at any time without notice. ISSI assumes no liability arising out of the application or use of any information, products or services described herein. Customers are advised to obtain the latest version of this device specification before relying on any published information and before placing orders for products.

Integrated Silicon Solution, Inc. does not recommend the use of any of its products in life support applications where the failure or malfunction of the product can reasonably be expected to cause failure of the life support system or to significantly affect its safety or effectiveness. Products are not authorized for use in such applications unless Integrated Silicon Solution, Inc. receives written assurance to its satisfaction, that:

- a.) the risk of injury or damage has been minimized;
- b.) the user assume all such risks; and
- c.) potential liability of Integrated Silicon Solution, Inc is adequately protected under the circumstances

IS31AP2006

ABSOLUTE MAXIMUM RATINGS

Supply voltage, V_{CC}	-0.3V ~ +6.0V
Voltage at any input pin	-0.3V ~ $V_{CC}+0.3V$
Maximum junction temperature, T_{JMAX}	150°C
Storage temperature range, T_{STG}	-65°C ~ +150°C
Operating temperature range, T_A	-40°C ~ +85°C
ESD (HBM)	7kV
ESD (CDM)	500V

Note:

Stresses beyond those listed under “Absolute Maximum Ratings” may cause permanent damage to the device. These are stress ratings only and functional operation of the device at these or any other condition beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

ELECTRICAL CHARACTERISTICS

$V_{CC} = 2.7V \sim 5.5V$, $T_A = 25^\circ C$, unless otherwise noted.

Symbol	Parameter	Condition	Min.	Typ.	Max.	Unit
V_{CC}	Supply voltage		2.7		5.5	V
$ V_{OS} $	Output offset voltage (measured differentially)	$V_{SDB} = 0V$, $A_V = 2V/V$		10		mV
I_{CC}	Quiescent current	$V_{CC} = 5.5V$, no load		2.6		mA
		$V_{CC} = 2.7V$, no load		1.2		
I_{SD}	Shutdown current	$V_{SDB} = 0.4V$			1	μA
f_{SW}	Switching frequency			250		kHz
R_{IN}	Input resistor	Gain $\leq 20V/V$	15			k Ω
Gain	Input gain	$R_{IN} = 150k\Omega$		2		V/V
V_{IH}	High-level input voltage		1.4			V
V_{IL}	Low-level input voltage				0.4	V

IS31AP2006

ELECTRICAL CHARACTERISTICS (NOTE 1)

$T_A = 25^\circ\text{C}$, Gain= 2V/V.

Symbol	Parameter	Condition	Min.	Typ.	Max.	Unit
P_O	Output power	THD+N = 10% $f = 1\text{kHz}$, $R_L = 8\Omega$	$V_{CC} = 5.0\text{V}$	1.70		W
			$V_{CC} = 4.2\text{V}$	1.20		
			$V_{CC} = 3.6\text{V}$	0.83		
		THD+N = 10% $f = 1\text{kHz}$, $R_L = 4\Omega$	$V_{CC} = 5.0\text{V}$	3		W
			$V_{CC} = 4.2\text{V}$	2.05		
			$V_{CC} = 3.6\text{V}$	1.55		
		THD+N = 1% $f = 1\text{kHz}$, $R_L = 8\Omega$	$V_{CC} = 5.0\text{V}$	1.45		W
			$V_{CC} = 4.2\text{V}$	0.95		
			$V_{CC} = 3.6\text{V}$	0.66		
		THD+N=1% $f = 1\text{kHz}$, $R_L = 4\Omega$	$V_{CC} = 5.0\text{V}$	2.50		W
			$V_{CC} = 4.2\text{V}$	1.70		
			$V_{CC} = 3.6\text{V}$	1.25		
THD+N	Total harmonic distortion plus noise	$V_{CC} = 5.0\text{V}$, $P_O = 1.0\text{W}$, $R_L = 8\Omega$, $f = 1\text{kHz}$		0.28		%
		$V_{CC} = 5.0\text{V}$, $P_O = 1.2\text{W}$, $R_L = 4\Omega$, $f = 1\text{kHz}$		0.31		
V_N	Output voltage noise	$V_{CC} = 3.6\text{V} \sim 5\text{V}$, $f = 20\text{Hz}$ to 20kHz , inputs ac-grounded with $C_I = 1\mu\text{F}$ A-Weighting		68		μVrms
t_{WU}	Wake-up time from shutdown	$V_{CC} = 3.6\text{V}$		36		ms
SNR	Signal-to-noise ratio	$P_O = 1.0\text{W}$, $R_L = 8\Omega$, $V_{CC} = 5.0\text{V}$		92		dB
PSRR	Power supply rejection ratio	$V_{CC} = 2.5\text{V} \sim 5.5\text{V}$		-55		dB

Note 1: Guaranteed by design.

TYPICAL PERFORMANCE CHARACTERISTICS

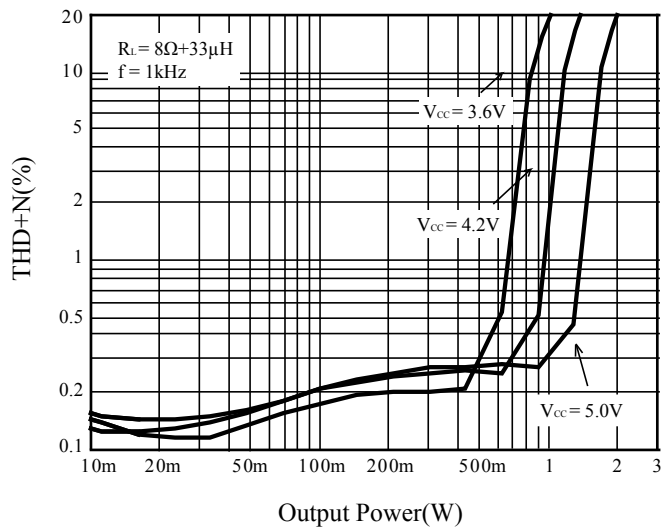


Figure 3 THD+N vs. Output Power

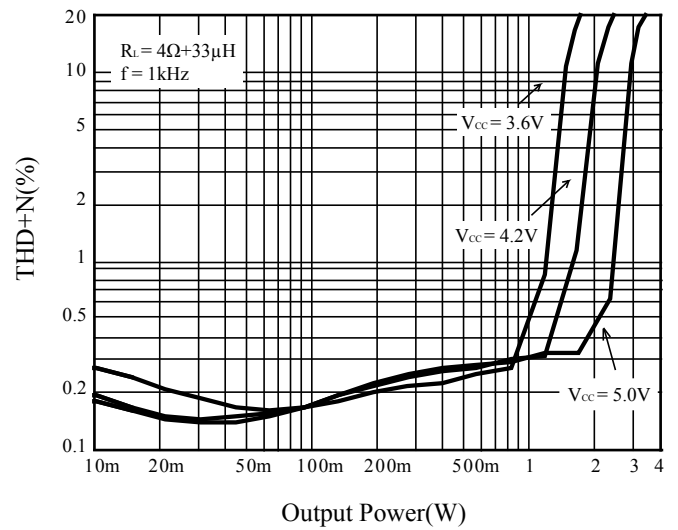


Figure 4 THD+N vs. Output Power

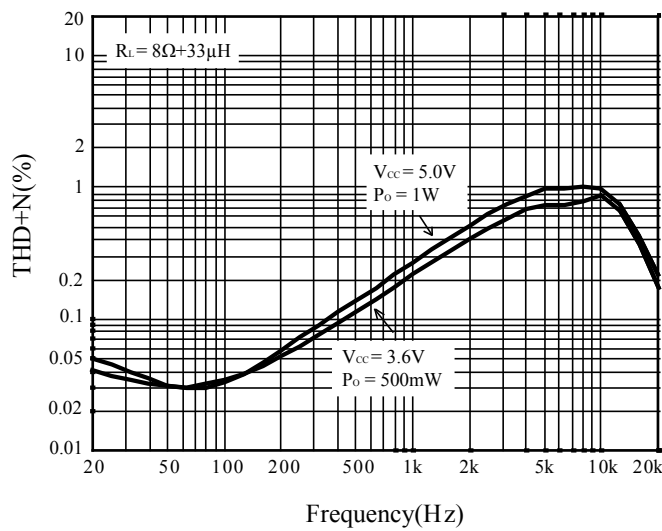


Figure 5 THD+N vs. Frequency

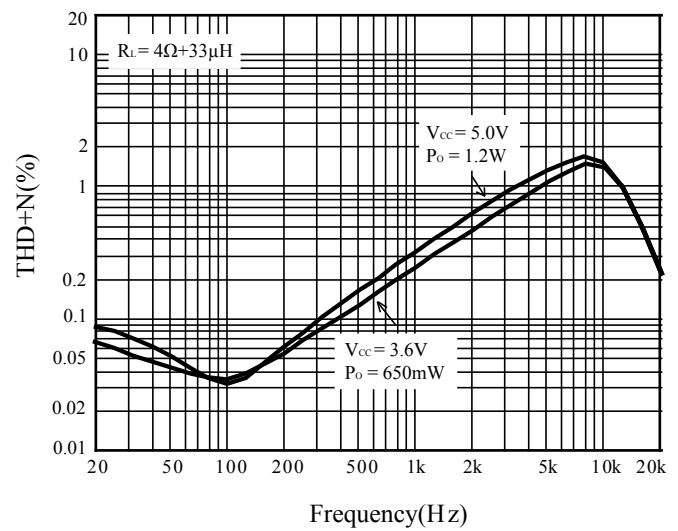


Figure 6 THD+N vs. Frequency

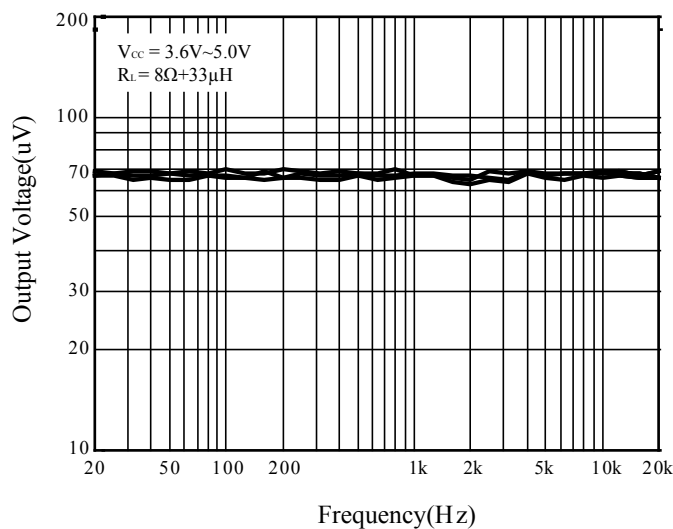


Figure 7 Noise

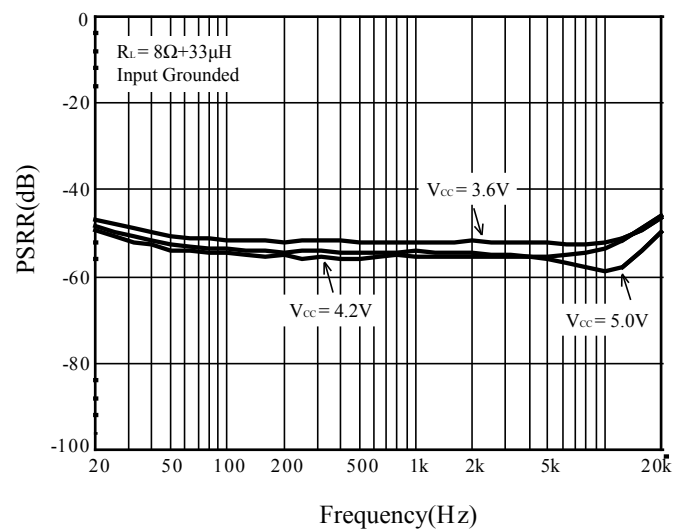


Figure 8 PSRR vs. Frequency

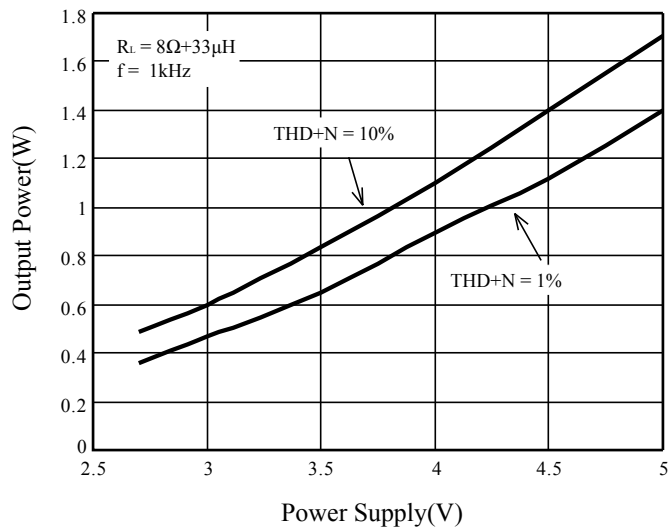


Figure 9 Output Power vs. Supply Voltage

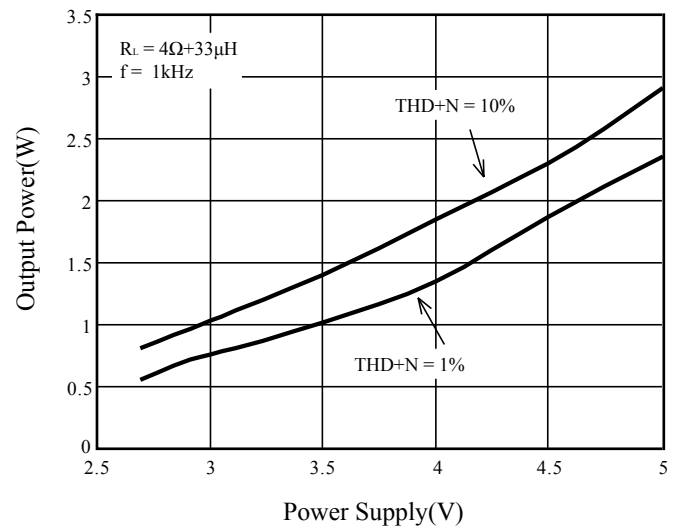


Figure 10 Output Power vs. Supply Voltage

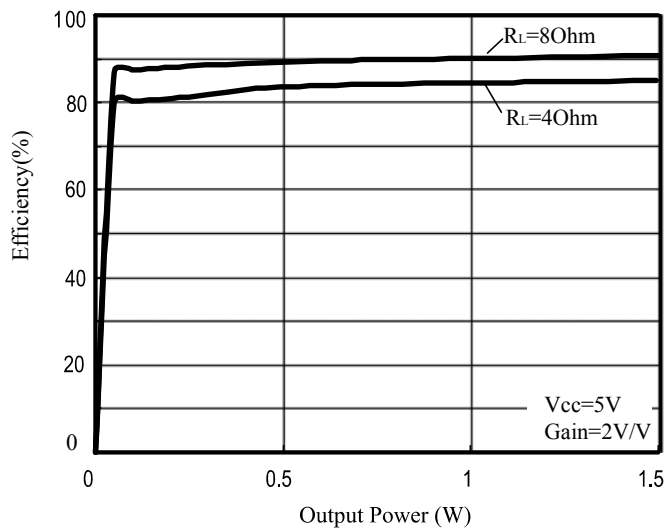
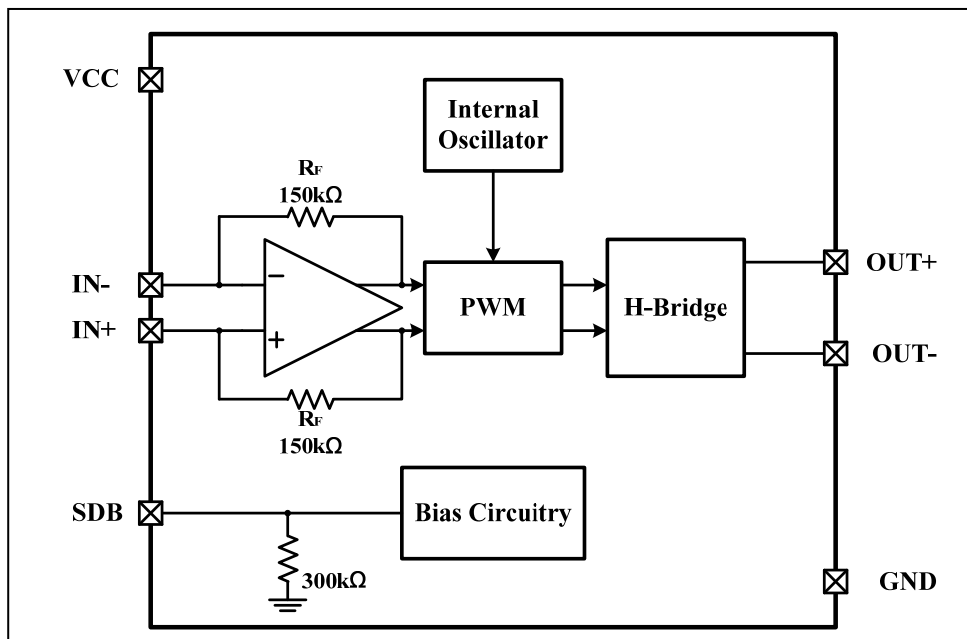


Figure 11 Efficiency vs. Output Power

IS31AP2006

FUNCTIONAL BLOCK DIAGRAM



IS31AP2006

APPLICATION INFORMATION

FULLY DIFFERENTIAL AMPLIFIER

The IS31AP2006 is a fully differential amplifier with differential inputs and outputs. The fully differential amplifier consists of a differential amplifier and a common-mode amplifier. The differential amplifier ensures that the amplifier outputs a differential voltage on the output that is equal to the differential input times the gain. The common-mode feedback ensures that the common-mode voltage at the output is biased around $V_{CC}/2$ regardless of the common-mode voltage at the input. The fully differential IS31AP2006 can still be used with a single-ended input; however, the IS31AP2006 should be used with differential inputs when in a noisy environment, like a wireless handset, to ensure maximum noise rejection.

ADVANTAGES OF FULLY DIFFERENTIAL AMPLIFIERS

The fully differential amplifier does not require a bypass capacitor. This is because any shift in the midsupply affects both positive and negative channels equally and cancels at the differential output.

GSM handsets save power by turning on and shutting off the RF transmitter at a rate of 217Hz. The transmitted signal is picked-up on input and output traces. The fully differential amplifier cancels the signal much better than the typical audio amplifier.

COMPONENT SELECTION

Figure 12 shows the IS31AP2006 with differential inputs and optional input capacitors. Input capacitors are used when the common mode input voltage range specs can not be guaranteed or high pass filter is considered.

Figure 13 shows the IS31AP2006 with single-ended inputs. The input capacitors have to be used in the single ended case because it is much more susceptible to noise in this case.

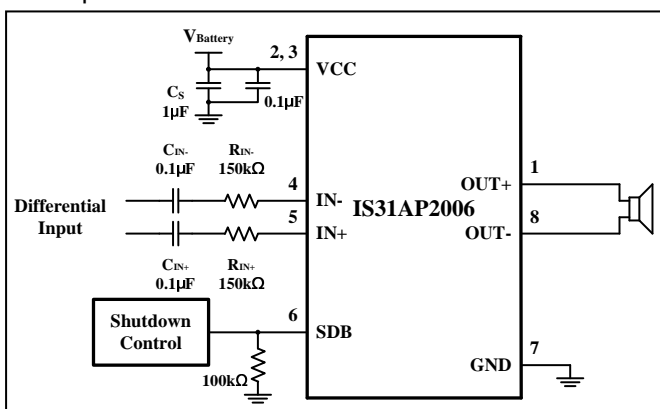


Figure 12 Typical Application Circuit with Differential Input

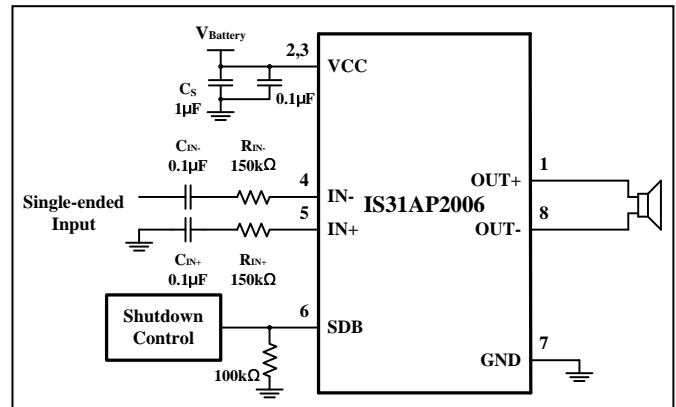


Figure 13 Typical Application Circuit with Single-Ended Input

INPUT RESISTORS (R_{IN})

The input resistors (R_{IN}) set the gain of the amplifier according to equation (1).

$$Gain = \frac{2 \times 150k\Omega}{R_{IN}} \left(\frac{V}{V} \right) \quad (1)$$

Resistor matching is very important in fully differential amplifiers. The balance of the output on the reference voltage depends on matched ratios of the resistors. CMRR, PSRR, and cancellation of the second harmonic distortion diminish if resistor mismatch occurs. Therefore, it is recommended to use 1% accuracy resistors or better to keep the performance optimized. Matching is more important than overall accuracy.

Place the input resistors close to the IS31AP2006 to reduce noise injection on the high-impedance nodes.

For optimal performance the gain should be set to 2V/V or lower. Lower gain allows the IS31AP2006 to operate at its best, and keeps a high voltage at the input making the inputs less susceptible to noise.

DECOUPLING CAPACITOR (C_S)

The IS31AP2006 is a high-performance Class-D audio amplifier that requires adequate power supply decoupling to ensure high efficiency and low total harmonic distortion (THD). For higher frequency transients, spikes, or digital noises on the line, a good low equivalent-series-resistance (ESR) ceramic capacitor, typically 1µF, placed as close as possible to the device V_{CC} pin works best. Placing this decoupling capacitor close to the IS31AP2006 is also important for the efficiency of the Class-D amplifier, because any resistance or inductance in the trace between the device and the capacitor can cause a loss in efficiency. For filtering lower-frequency noise signals, a 10µF or greater capacitor placed near the audio power amplifier would also be helpful, but it is not required in most applications because of better PSRR of this device.

IS31AP2006

INPUT CAPACITORS (C_{IN})

The input capacitors and input resistors form a high-pass filter with the corner frequency, f_c , determined in equation (2).

$$f_c = \frac{1}{(2\pi R_{IN} C_{IN})} \quad (2)$$

The value of the input capacitor is important to consider as it directly affects the bass (low frequency) performance of the circuit. Speakers in wireless phones cannot usually respond well to low frequencies, so the corner frequency can be set to block low frequencies in this application.

Equation (3) is reconfigured to solve for the input coupling capacitance.

$$C_{IN} = \frac{1}{(2\pi R_{IN} f_c)} \quad (3)$$

If the corner frequency is within the audio band, the capacitors should have a tolerance of $\pm 10\%$ or better, because any mismatch in capacitance causes an impedance mismatch at the corner frequency and below.

For a flat low-frequency response, use large input coupling capacitors (1 μ F). However, in a GSM phone the ground signal is fluctuating at 217Hz, but the signal from the codec does not have the same 217Hz fluctuation. The difference between the two signals is amplified, sent to the speaker, and heard as a 217Hz hum.

SUMMING INPUT SIGNALS

Most wireless phones or PDAs need to sum signals at the audio power amplifier or just have two signal sources that need separate gain. The IS31AP2006 makes it easy to sum signals or use separate signal sources with different gains. Many phones now use the same speaker for the earpiece and ringer, where the wireless phone would require a much lower gain for the phone earpiece than for the ringer. PDAs and phones that have stereo headphones require summing of the right and left channels to output the stereo signal to the mono speaker.

SUMMING TWO DIFFERENTIAL INPUT SIGNALS

Two extra resistors are needed for summing differential signals. The gain for each input source can be set independently (see equations (4) and (5), and Figure 14).

$$Gain1 = \frac{2 \times 150k\Omega}{R_{IN1}} \left(\frac{V}{V} \right) \quad (4)$$

$$Gain2 = \frac{2 \times 150k\Omega}{R_{IN2}} \left(\frac{V}{V} \right) \quad (5)$$

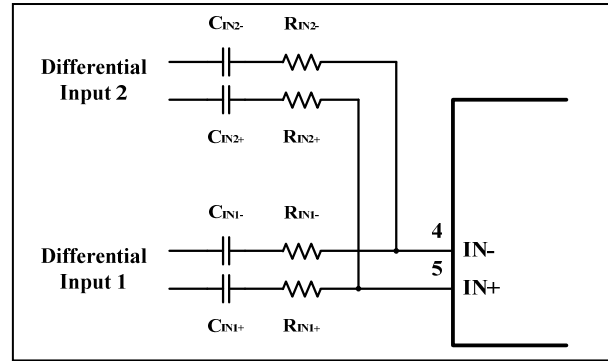


Figure 14 Application Circuit with Summing Two Differential Inputs

If summing left and right inputs with a gain of 1V/V, use $R_{IN1} = R_{IN2} = 300k\Omega$.

If summing a ring tone and a phone signal, set the ring-tone gain to $Gain2 = 2V/V$, and the phone gain to $Gain1 = 0.1V/V$. The resistor values would be.

$R_{IN1} = 3M\Omega$, and $R_{IN2} = 150k\Omega$.

SUMMING A DIFFERENTIAL INPUT SIGNAL AND A SINGLE-ENDED INPUT SIGNAL

Figure 15 shows how to sum a differential input signal and a single-ended input signal. Ground noise may couple in through IN- with this method. It is better to use differential inputs. The corner frequency of the single-ended input is set by C_{IN2} , shown in equation (8). To assure that each input is balanced, the single-ended input must be driven by a low-impedance source even if the input is not in use.

$$Gain1 = \frac{2 \times 150k\Omega}{R_{IN1}} \left(\frac{V}{V} \right) \quad (6)$$

$$Gain2 = \frac{2 \times 150k\Omega}{R_{IN2}} \left(\frac{V}{V} \right) \quad (7)$$

$$C_{IN2} = \frac{1}{(2\pi R_{IN2} f_{c2})} \quad (8)$$

If summing a ring tone and phone signals, the phone signals should use the differential inputs while the ring tone should use the single-ended input. The phone gain is set at $Gain2 = 0.1V/V$, and the ring-tone gain is set to $Gain2 = 0.1V/V$, the resistor values would be

$R_{IN1} = 150k\Omega$, and $R_{IN2} = 3M\Omega$

The high pass corner frequency of the single-ended input is set by C_{IN2} . If the desired corner frequency is less than 20Hz.

$$C_{IN1} = \frac{1}{2\pi R_{IN1} f_{c1}} \quad (9)$$

$$C_{IN2} > 53 pF \quad (10)$$

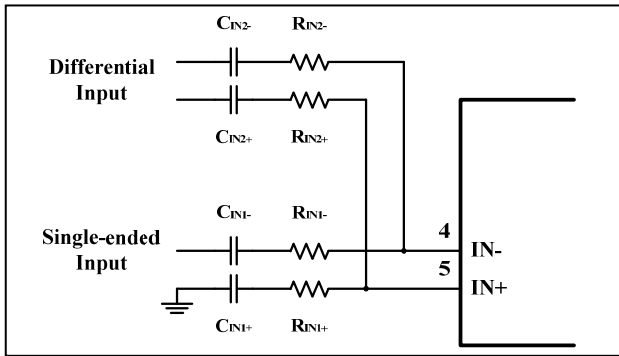


Figure 15 Application Circuit with Summing Differential Input and Single-Ended Input Signals

SUMMING TWO SINGLE-ENDED INPUT SIGNALS

The gain and corner frequencies (f_{C1} and f_{C2}) for each input source can be set independently (see equations (11) through (14), and Figure 16). Resistor, R_P , and capacitor, C_P , are needed on the IN+ terminal to match the impedance on the IN- terminal.

The single-ended inputs must be driven by low impedance sources.

$$Gain1 = \frac{2 \times 150k\Omega}{R_{IN1}} \left(\frac{V}{V} \right) \quad (11)$$

$$Gain2 = \frac{2 \times 150k\Omega}{R_{IN2}} \left(\frac{V}{V} \right) \quad (12)$$

$$C_{IN1} = \frac{1}{2\pi R_{IN1} f_{C1}} \quad (13)$$

$$C_{IN2} = \frac{1}{2\pi R_{IN2} f_{C2}} \quad (14)$$

$$C_P = C_{IN1} + C_{IN2} \quad (15)$$

$$R_P = \frac{R_{IN1} \times R_{IN2}}{(R_{IN1} + R_{IN2})} \quad (16)$$

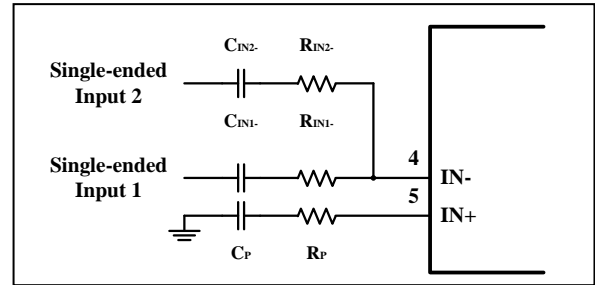


Figure 16 Application Circuit with Summing Two Single-Ended Inputs

CLASSIFICATION REFLOW PROFILES

Profile Feature	Pb-Free Assembly
Preheat & Soak Temperature min (T _{sm}) Temperature max (T _{sm}) Time (T _{sm} to T _{sm}) (t _s)	150°C 200°C 60-120 seconds
Average ramp-up rate (T _{sm} to T _p)	3°C/second max.
Liquidous temperature (T _L) Time at liquidous (t _L)	217°C 60-150 seconds
Peak package body temperature (T _p)*	Max 260°C
Time (t _p)** within 5°C of the specified classification temperature (T _c)	Max 30 seconds
Average ramp-down rate (T _p to T _{sm})	6°C/second max.
Time 25°C to peak temperature	8 minutes max.

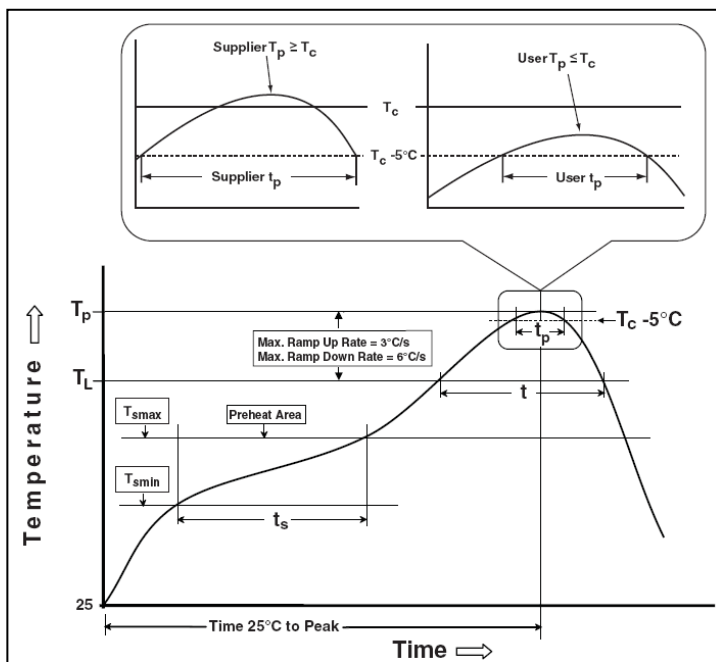
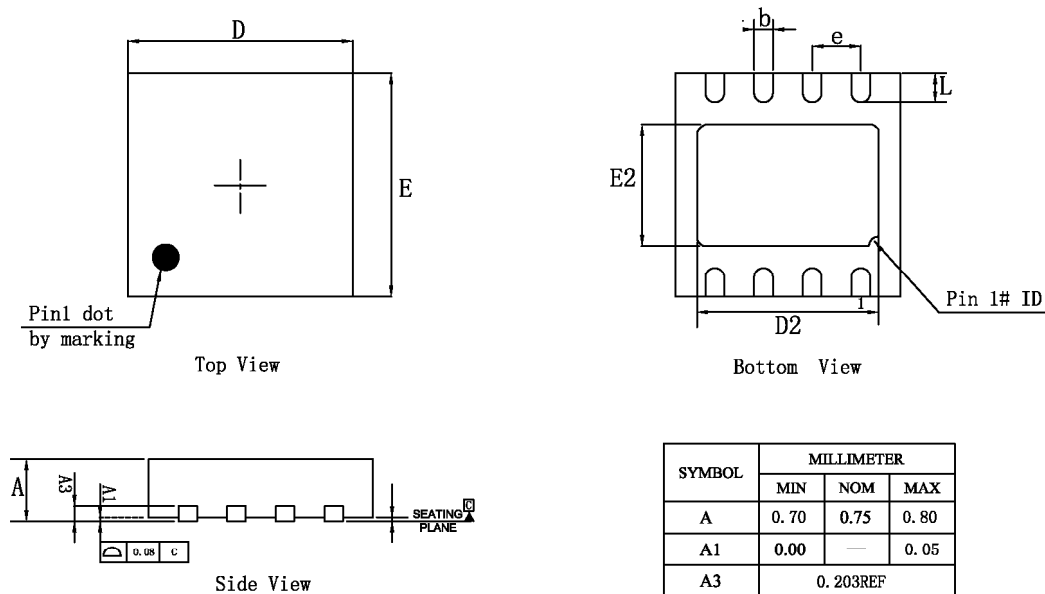


Figure 17 Classification Profile

IS31AP2006

PACKAGING INFORMATION

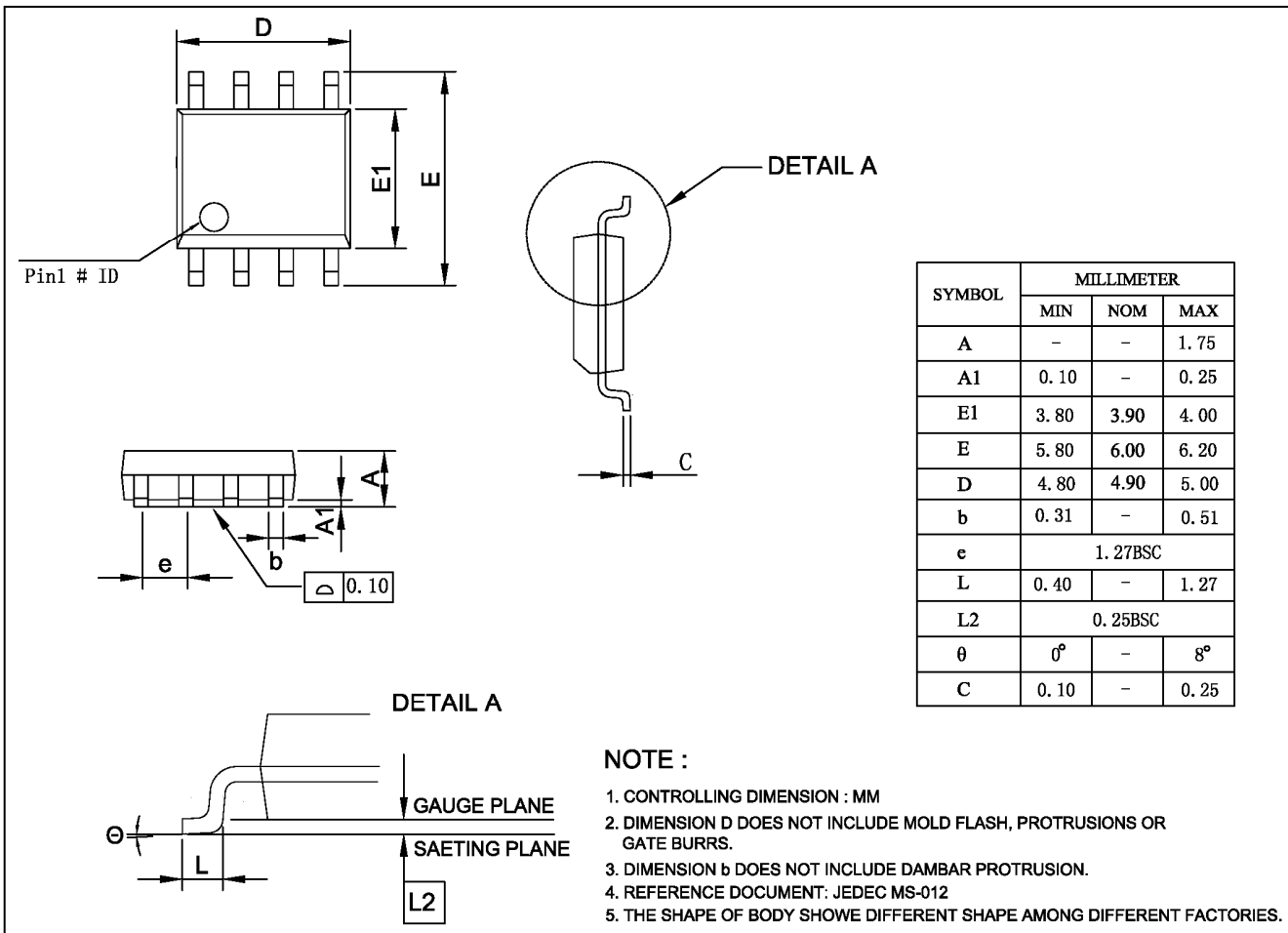
DFN-8



SYMBOL	MILLIMETER		
	MIN	NOM	MAX
A	0.70	0.75	0.80
A1	0.00	—	0.05
A3	0.203REF		
D	2.90	3.00	3.10
E	2.90	3.00	3.10
E2	1.35	—	1.75
D2	2.15	—	2.55
b	0.17	—	0.35
L	0.30	0.40	0.575
e	0.65 BSC		

NOTES:

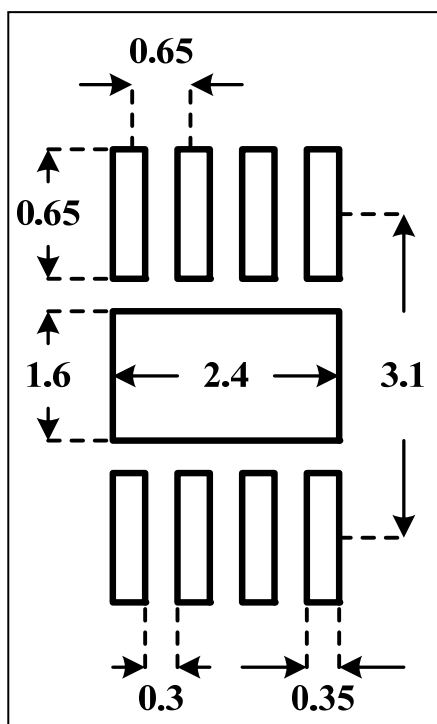
The thermal pad shows different shape among different factories.



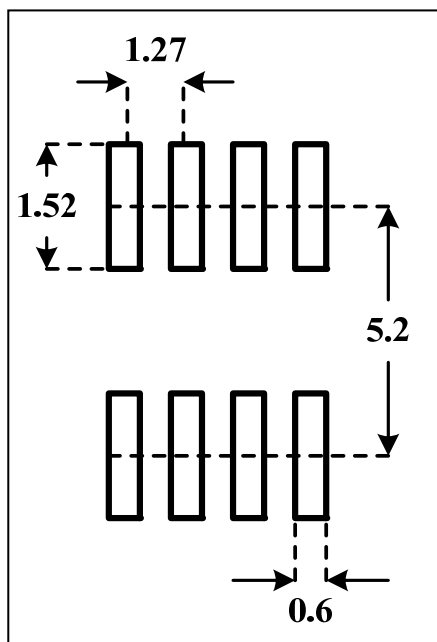
IS31AP2006

RECOMMENDED LAND PATTERN

DFN-8



SOP-8



Note:

1. Land pattern complies to IPC-7351.
2. All dimensions in MM.
3. This document (including dimensions, notes & specs) is a recommendation based on typical circuit board manufacturing parameters. Since land pattern design depends on many factors unknown (eg. user's board manufacturing specs), user must determine suitability for use.

IS31AP2006

REVISION HISTORY

Revision	Detail Information	Date
A	Initial release	2012.03.27
B	1. Add ESD(CDM) 2. Add SOP-8 package 2. Add land pattern	2015.08.17